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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

First Named Inventor:	Luca PUSTERLA,	§	
	et al.	§	
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Conf. No.:	Not Yet Assigned	§	Group Art Unit: Not Yet Assigned
		§	
Appln. No.:	Not Yet Assigned	§	Examiner: Not Yet Assigned
		§	
Filing Date:	Herewith	§	Attorney Docket No.: 6023-170US
		§	(BX2390M)
Title:	METHOD FOR MEASURING THE CONCENTRATION OF WATER IN ARGON, HYDROGEN, NITROGEN AND HELIUM BY MEANS OF IONIZATION MOBILITY SPECTROMETRY		

INFORMATION DISCLOSURE STATEMENT UNDER 37 C.F.R. §1.97(b)

Enclosed are copies of each of the documents listed on the attached Information Disclosure Citation Form(s) PTO/SB/08A and/or B, which may be material to the patentability of this application and/or for which there may be a duty to disclose in accordance with 37 C.F.R. §1.56.

The enclosed references were cited in an International Search Report (copy enclosed) dated January 27, 2003 from the European Patent Office concerning counterpart International Application No. PCT/IT02/00370 and/or cited and discussed at pages 1-4 of the specification.

The filing of this Information Disclosure Statement shall not be construed as an admission that any of the listed documents constitutes prior art, nor as an admission against interest in any manner.

No fee is believed to be due in connection with the filing of this Information Disclosure Statement since it is being filed within three months of the filing date of the above-identified application. However, the Commissioner is hereby authorized to charge any deficiencies or credit any overpayments to Deposit Account No. 50-1017.

It is respectfully requested that this Information Disclosure Statement and the documents listed on the attached Form PTO/SB/08A and/or B be considered and acknowledged by the Examiner in connection with the above-identified patent application, be made of record therein, and that the listed document(s) be cited in the issued patent.

Respectfully submitted,

Luca PUSTERLA, et al.

November 24, 2003

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WWS:sm
Enclosures

Form PTO/SB/08A		Complete If Known	
INFORMATION DISCLOSURE STATEMENT BY APPLICANT (use as many sheets as necessary)		Application Number	Not Yet Assigned
		Filing Date	Herewith
		First Named Inventor	Luca PUSTERLA, et al.
		Group Art Unit	Not Yet Assigned
		Examiner Name	Not Yet Assigned
Sheet 1 of 1	Attorney Docket Number		6023-170US (BX2390M)

U.S. PATENT DOCUMENTS				
Exr Initials	U.S. Patent Document		Name of First Inventor of Cited Document	Date of Publication of Cited Document MM-YYYY
	Number	Kind Code (if known)		
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FOREIGN PATENT DOCUMENTS						
Exr Initials	Foreign Patent Document			Name of Applicant of Cited Document	Date of Publication of Cited Document MM-YYYY	T ₁
	Country Code	Number	Kind Code (if known)			
	GB	2 177 079	A	Taiyo Sanso Co. Ltd.	01-1987	
	GB	2 177 080	A	Taiyo Sanso Co. Ltd.	01-1987	

OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS		
Exr Initials	Include Name of first Author (in CAPITAL LETTERS), title of the article (where appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), volume-issue number(s), page(s), date (in parentheses). If a book, also include publisher and city and/or county where published.	T ₁
	STIMAC et al., "Water Vapor Measurements In Small Volumes Using Atmospheric Pressure Chemical Ionization – Mass Spectrometry", <i>Proceedings of the Annual Symposium On Reliability Physics.</i> , Vol. Proc. 20, pp. 260-263, (1982)	
	STIMAC et al., "Use Of Ion Mobility Spectrometry To Determine Trace Level Impurities In Ultra High Purity Gases" <i>proceedings Institute Of Environmental Sciences</i> , pp. 5-12, (1996)	

Examiner Signature		Date Considered	
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